MOSFET – Single P-Channel, Small Signal, XDFN3, 0.62 x 0.42 x 0.4 mm

• Low Profile Ultra Small Package, XDFN3 (0.62 x 0.42 x 0.4 mm)

• These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS



ON Semiconductor®

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V _{(BR)DSS}	R _{DS(on)} MAX	I _D Max
	5.0 Ω @ –4.5 V	
	5.5 Ω @ –3.3 V	
–20 V	6.0 Ω @ –2.5 V	–127 mA
	7.0 Ω @ –1.8 V	
	10 Ω @ –1.5 V	

Applications

Compliant

• -1.5 V Gate Drive

Features

• Small Signal Load Switch

NTNS2K1P021Z

-20 V, -127 mA

- High Speed Interfacing
- Level Shift

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

for Extremely Space-Constrained Applications

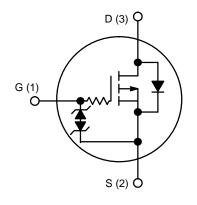
Para	Parameter					
Drain-to-Source Volt	Drain-to-Source Voltage					
Gate-to-Source Volta	Gate-to-Source Voltage					
Continuous Drain	Steady	$T_A = 25^{\circ}C$	Ι _D	-127	mA	
Current (Note 1)	State	$T_A = 85^{\circ}C$		-91		
	t ≤ 5 s	$T_A = 25^{\circ}C$		-146		
Power Dissipation (Note 1)	Steady State	$T_A = 25^{\circ}C$	PD	125	mW	
	t ≤ 5 s			166		
Pulsed Drain Current	t _p =	10 μs	I _{DM}	-488	mA	
Operating Junction ar Temperature Range	nd Storage		T _J , T _{STG}	–55 to 150	°C	
Source Current (Body	۱ _S	200	mA			
	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)				°C	
	e a Part a d'Anna		D. //			

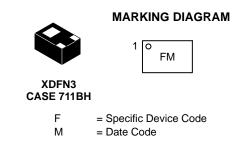
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using the minimum recommended pad size, or 2 mm², 1 oz Cu.

2. Pulse Test: pulse width \leq 300 µs, duty cycle \leq 2%

P-CHANNEL MOSFET





ORDERING INFORMATION

Device	Package	Shipping [†]
NTNS2K1P021ZTCG	XDFN3 (Pb-Free)	8000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

NTNS2K1P021Z

THERMAL RESISTANCE RATINGS

Parameter		Мах	Unit
Junction-to-Ambient - Steady State (Note 3)	R _{θJA}	998	°C/W
Junction-to-Ambient – t \leq 5 s (Note 3)	R_{\thetaJA}	751	C/W

3. Surface–mounted on FR4 board using the minimum recommended pad size, or 2 mm², 1 oz Cu.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -25$	0 μΑ	-20			V
Zero Gate Voltage Drain Current	I _{DSS}	V_{GS} = 0 V, V_{DS} = -5 V	$T_J = 25^{\circ}C$			-50	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V, V_{DS} = -16 V$	$T_J = 25^{\circ}C$			-100	nA
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±	±5 V			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = -28$	50 μΑ	-0.4		-1.0	V
		$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -100 \text{ mA}$			2.1	5.0	Ω
	R _{DS(on)}	$V_{GS} = -3.3 \text{ V}, \text{ I}_{D} = -100 \text{ mA}$			2.4	5.5	
Drain-to-Source On Resistance		$V_{GS} = -2.5 \text{ V}, \text{ I}_{D} = -50 \text{ mA}$			2.7	6.0	
		$V_{GS} = -1.8 \text{ V}, \text{ I}_{D} = -20 \text{ mA}$			3.6	7.0	
		V_{GS} = -1.5 V, I _D = -10 mA			4.2	10	
Forward Transconductance	9fs	$V_{DS} = -5 \text{ V}, \text{ I}_{D} = -125 \text{ mA}$			0.35		S
Source-Drain Diode Voltage	V _{SD}	$V_{GS} = 0 V, I_{S} = -10 mA$			-0.6	-1.0	V
CHARGES & CAPACITANCES							
Input Capacitance	C _{ISS}				12.8		
Output Capacitance	C _{OSS}	$V_{GS} = 0 V$, freq = 1 MHz, V	√ _{DS} = −15 V		2.8		pF
Reverse Transfer Capacitance	C _{RSS}				2.0		
SWITCHING CHARACTERISTICS, VG	S = 4.5 V (Not	e 4)					
Turn-On Delay Time	t _{d(ON)}				37		
Rise Time	t _r	V _{GS} = -4.5 V, V _{DD} = -15 V,			71		
Turn–Off Delay Time	t _{d(OFF)}	$I_{\rm D} = 200 \text{ mA}, \text{ R}_{\rm G} =$	2Ω		280		ns

171

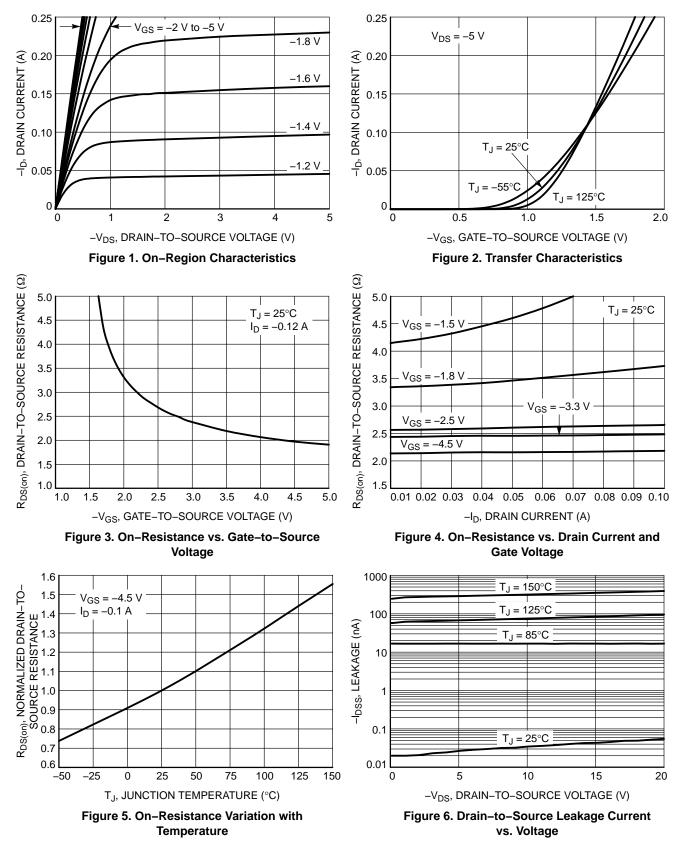
4. Switching characteristics are independent of operating junction temperatures.

t_f

Fall Time

NTNS2K1P021Z

TYPICAL CHARACTERISTICS



NTNS2K1P021Z

TYPICAL CHARACTERISTICS

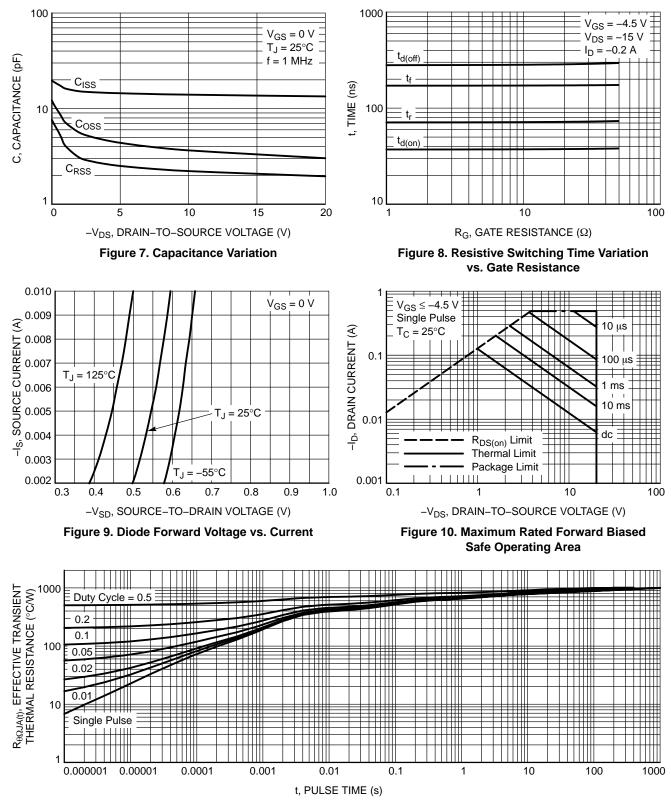
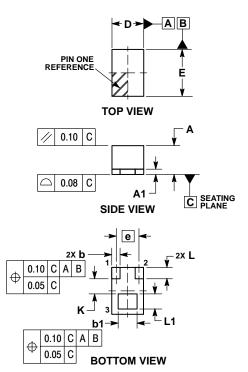


Figure 11. Thermal Response

PACKAGE DIMENSIONS

XDFN3 0.42x0.62, 0.3P CASE 711BH ISSUE O



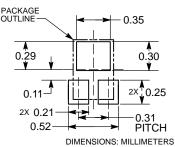
NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION b AND b1 APPLIES TO THE PLATED
- 3. DIMENSION DAND BEAFFLIED TO THE FEATED TERMINALS AND IS MEASURED BETWEEN 0.20 AND 0.25MM FROM THE TERMINAL TIP.

4.	COPI	LANA	(KII)	(APP	LIES	10	THE	PLAIED	IERM	I-
	NALS	S.								

	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	0.33	0.38	0.43			
A1			0.07			
b	0.05	0.11	0.17			
b1			0.30			
D						
Е	0.52	0.62	0.72			
е	0.30 BSC					
L	0.09	0.15	0.21			
L1	0.15	0.20	0.25			
κ	0.20 REF					

RECOMMENDED SOLDER FOOTPRINT*



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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